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Fairchild Semiconductor FCH76N60N

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November 2013

FCH76N60N

N-Channel SupreMOS[®] MOSFET 600 V, 76 A, 36 m Ω

Features

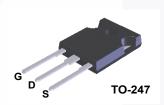
- $R_{DS(on)}$ = 28 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 38 A
- Ultra Low Gate Charge (Typ. Q_q = 218 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 914 pF)
- 100% Avalanche Tested
- · RoHS Compliant

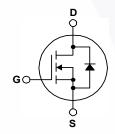
Application

- · Solar Inverter
- AC-DC Power Supply

Description

The SupreMOS[®] MOSFET is Fairchild Semiconductor's next generation of high voltage super-junction (SJ) technology employing a deep trench filling process that differentiates it from the conventional SJ MOSFETs. This advanced technology and precise process control provides lowest Rsp on-resistance, superior switching performance and ruggedness. SupreMOS MOSFET is suitable for high frequency switching power converter applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.





MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol		Parameter	FCH76N60N	Unit	
V _{DSS}	Drain to Source Voltage		600	V	
V _{GSS}	Gate to Source Voltage		±30	V	
	Drain Current	- Continuous (T _C = 25°C)	76	^	
^I D	Drain Current	- Continuous (T _C = 100°C)	48.1	A	
I _{DM}	Drain Current	- Pulsed (Note 1)	228	Α	
E _{AS}	Single Pulsed Avalanche Ener	gy (Note 2)	8022	mJ	
I _{AR}	Avalanche Current	(Note 1)	25.3	Α	
E _{AR}	Repetitive Avalanche Energy	5.43	mJ		
du/dt	MOSFET dv/dt		100	V/ma	
dv/dt Peak Diode Recovery dv		(Note 3)	20	V/ns	
n	Davis Dissipation	$(T_C = 25^{\circ}C)$	543	W	
P_{D}	Power Dissipation	- Derate above 25°C	4.34	W/°C	
T _J , T _{STG}	Operating and Storage Tempe	-55 to +150	οС		
T _L	Maximum Lead Temperature f	or Soldering, 1/8" from Case for 5 Seconds	300	οС	

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FCH76N60N	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 40		°C/VV



Datasheet of FCH76N60N - MOSFET N-CH 600V 76A TO-247 Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCH76N60N	FCH76N60N	TO-247	Tube	N/A	N/A	30 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}, T_C = 25^{\circ}\text{C}$	600	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C	-	0.73	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 480 V, V _{GS} = 0 V	-	-	10	
I _{DSS} Zero	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	-	100	μΑ
I _{GSS}	Gate to Body Leakage Current	V _{GS} = ±30 V, V _{DS} = 0 V	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 38 \text{ A}$	-	28	36	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 20 V, I _D = 38 A	-	90	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V = 400 V V = 0V	-	9310	12385	pF
C _{oss}	Output Capacitance	V _{DS} = 100 V, V _{GS} = 0V		370	495	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	-\	3.1	5	pF
C _{oss}	Output Capacitance	V _{DS} = 380 V, V _{GS} = 0 V, f = 1 MHz	-	195	-	pF
C _{oss(eff.)}	Effective Output Capacitance	V _{DS} = 0 V to 380 V, V _{GS} = 0 V	-	914	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V _{DS} = 380 V, I _D = 38 A,	-	218	285	nC
Q_{gs}	Gate to Source Gate Charge	V _{GS} = 10 V	-	39	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4)	-	66	-	nC
ESR	Equivalent Series Resistance(G-S)	f = 1 MHz	-	1.0	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	34	78	ns
t _r	Turn-On Rise Time	$V_{DD} = 380 \text{ V}, I_D = 38 \text{ A},$	-/	24	58	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$	-	235	480	ns
t _f	Turn-Off Fall Time	(Note 4)	-	32	74	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	76	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	228	Α
V_{SD}	Drain to Source Diode Forward Voltage V _{GS}	= 0 V, I _{SD} = 38 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time V _{GS}	= 0 V, I _{SD} = 38 A,	-	612	-	ns
Q _{rr}	Reverse Recovery Charge dI _F /o	dt = 100 A/μs	-	16	_	μC

Notes:

- Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. I_{AS} = 25.3 A, R_{G} = 25 Ω , starting T_{J} = 25°C.
- 3. I $_{SD} \leq$ 76 A, di/dt \leq 200 A/µs, V $_{DD} \leq$ 380 V, starting T $_{J}$ = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.



Typical Performance Characteristics

Figure 1. On-Region Characteristics

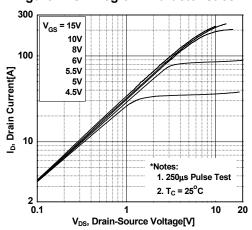


Figure 3. On-Resistance Variation vs. **Drain Current and Gate Voltage**

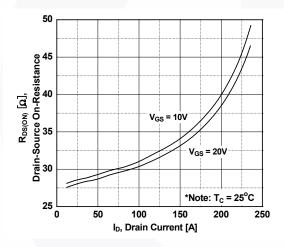


Figure 5. Capacitance Characteristics

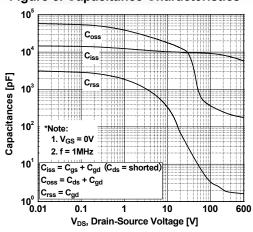


Figure 2. Transfer Characteristics

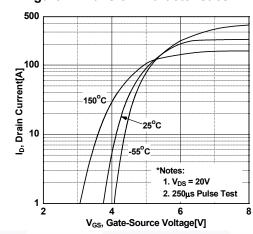


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

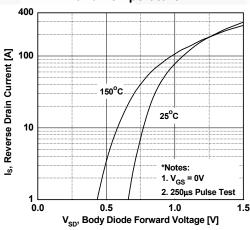
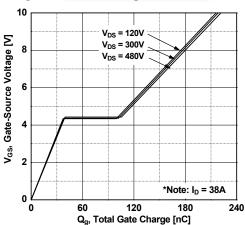


Figure 6. Gate Charge Characteristics





Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

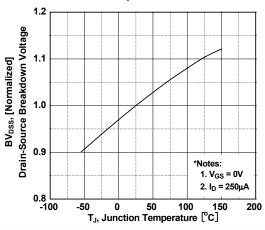


Figure 8. On-Resistance Variation vs. Temperature

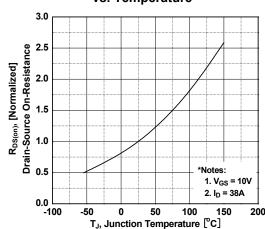


Figure 9. Maximum Safe Operating Area

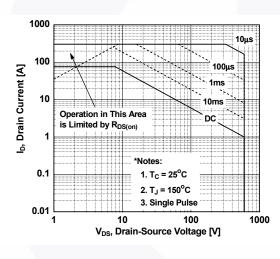


Figure 10. Maximum Drain Current vs. Case Temperature

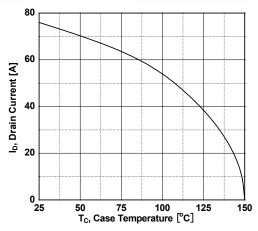
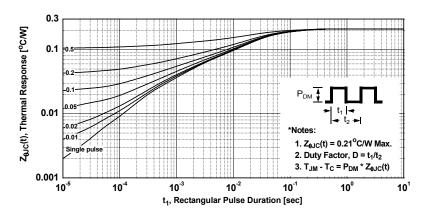


Figure 11. Transient Thermal Response Curve



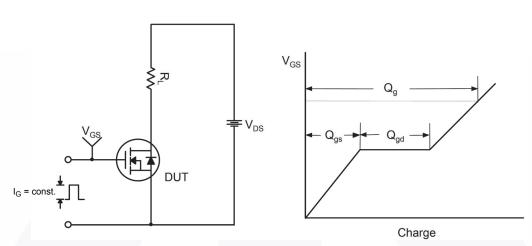


Figure 12. Gate Charge Test Circuit & Waveform

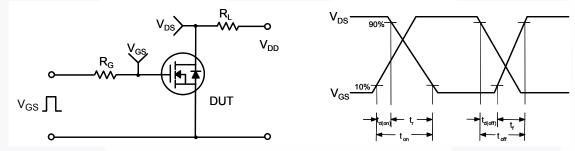


Figure 13. Resistive Switching Test Circuit & Waveforms

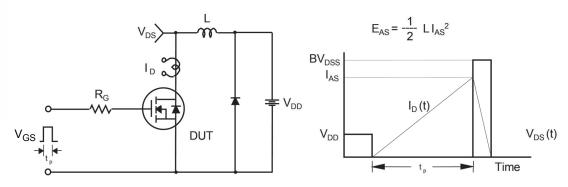
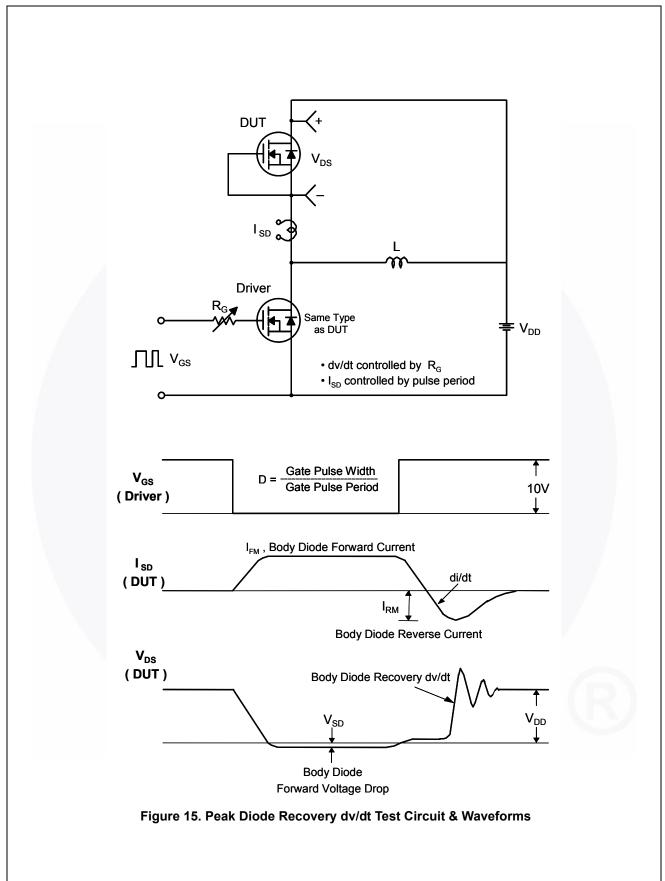
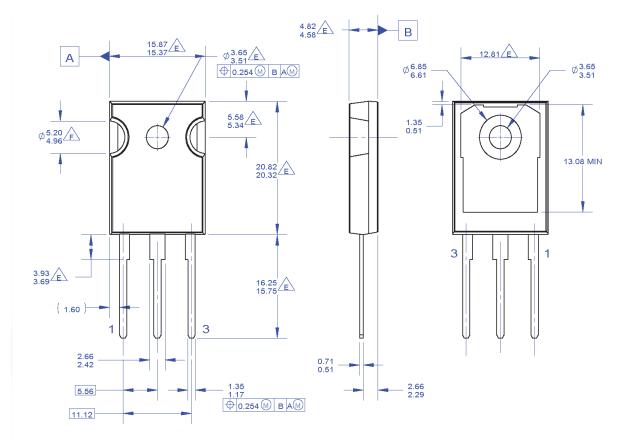


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms





Mechanical Dimensions



NOTES: UNLESS OTHERWISE SPECIFIED

- A. PACKAGE REFERENCE: JEDEC TO-247,
- ISSUE E, VARIATION AB, DATED JUNE, 2004.
 DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
- FLASH, AND TIE BAR EXTRUSIONS.
 ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994

DOES NOT COMPLY JEDEC STANDARD VALUE

E NOTCH MAY BE SQUARE

DRAWING FILENAME: MKT-TO247A03_REV03

Figure 16. TO-247, Molded, 3-Lead, Jedec Variation AB

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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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